Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/744,664	STRATTON ET AL.	
Examiner	Art Unit	

Christopher S. Kim

3752

SEARCHED .				
Class	Subclass	Date	Examiner	
239	700 703 214- 214.19 215 216			
	222.11			
	222.13			
	222.15			
	223	9/6/2005	ск	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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